

Notice of References Cited	Application/Control No. 10/674,421	Applicant(s)/Patent Under Reexamination CHAE ET AL.	
	Examiner WILLIAM L. BODDIE	Art Unit 2629	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,459,465	10-2002	Lee, Yun-Bok	349/141
*	B	US-6,356,328	03-2002	Shin et al.	349/141
	C	US-			
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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